

Notice of References Cited

Application/Control No.

10/500,401

Applicant(s)/Patent Under
Reexamination
OIWA ET AL.

Examiner

SYED HASAN

Art Unit

2484

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0066113	05-2002	Utsunomiya et al.	725/146
*	B	US-6,112,010	08-2000	Koyama et al.	386/241
*	C	US-2003/0081515	05-2003	Horii et al.	369/47.16
*	D	US-2002/0159186	10-2002	Kotani, Takuya	360/75
*	E	US-2002/0097986	07-2002	Matoba et al.	386/83
*	F	US-6,292,626	09-2001	Ino et al.	386/344
*	G	US-5,414,686	05-1995	Iitsuka, Hiroyuki	369/47.29
*	H	US-2002/0044503	04-2002	Yoshida, Masayoshi	369/30.16
*	I	US-5,067,029	11-1991	Takahashi, Yohnosuke	386/225
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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